

Automotive MOSFET

OptiMOS™ 6 Power-Transistor







Features

- OptiMOS[™] power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- Extended qualification beyond AEC-Q101
- PPAP Capable
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested



General automotive applications.

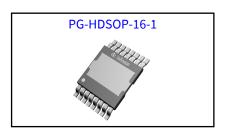
Product Validation

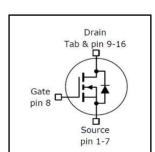
Qualified for automotive applications. Product validation according to AEC-Q101.

Product Summary

$V_{ m DS}$	150	V
R _{DS(on)}	3.8	mΩ
I _D (chip limited)	170	Α

Туре	Package	Marking
IAUTN15S6N038T	PG-HDSOP-16-1	6N15N038





IAUTN15S6N038T



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Maximum Ratings

at $T_j = 25$ °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	V _{GS} = 10 V, Chip limitation ^{1,2)}	170	А
		V _{GS} = 10 V, DC current	170	
		$T_a = 100$ °C, $V_{GS} = 10$ V, R_{thJH} on $2s2p^{2,4)}$	57	
Pulsed drain current ²⁾	I _{D,pulse}	$T_{\rm C}$ = 25°C, $t_{\rm p}$ = 100 μ s	602	1
Avalanche energy, single pulse ²⁾	E _{AS}	I _D = 85 A	285	mJ
Avalanche current, single pulse	I _{AS}	-	170	А
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P _{tot}	T _C = 25°C	250	W
Operating temperature	T _j	-	-55 +175	°C

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Thermal Characteristics²⁾

Parameter	Sumbol Conditions	Values			limit.	
	Symbol	Symbol Conditions	min.	typ.	max.	Unit
Thermal resistance, junction - case	R_{thJC}	-	-		0.6	K/W
Thermal characterisation parameter, source pin ⁵⁾	ψ_{source}	-	-	1.0	-	
Thermal characterisation parameter, drain pin ⁶⁾	Ψ _{drain}	-	-	0.9	-	
Thermal resistance, junction - heatsink ⁴⁾	R _{thJH}	-	_	2.6	-	
Thermal resistance, junction - ambient ³⁾	R_{thJA}	-	_	29.1	_	

Electrical Characteristics

at T_j=25 °C, unless otherwise specified

Parameter	Cumbal	nbol Conditions		Values		
	Symbol	Conditions	min.	typ.	max.	Unit
Static Characteristics						
Drain-source breakdown voltage	V _{(Br)DSS}	$V_{GS} = 0 \text{ V},$ $I_D = 1 \text{ mA}$	150	-	-	V
Gate threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 166 \mu\text{A}$	3	3.5	4	
		$V_{DS} = 120 \text{ V}, V_{GS} = 0 \text{ V}, T_j = 25^{\circ}\text{C}$	-	-	1	μΑ
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 120 \text{ V}, V_{GS} = 0 \text{ V},$ $T_j = 100^{\circ}\text{C}^{2j}$	-	-	100	
Gate-source leakage current	I _{GSS}	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	100	nA
During the second secon	_	$V_{GS} = 8 \text{ V}, I_D = 43 \text{ A}$	-	3.7	4.8	mΩ
Drain-source on-state resistance	R _{DS(on)}	$V_{\rm GS} = 10 \text{V}, I_{\rm D} = 85 \text{A}$	-	3.3	3.8	
Gate resistance ²⁾	R _G	-	_	1.0	_	Ω





Parameter	Symbol Conditions	Values			11:4:4		
	Symbol		min.	typ.	max.	Unit	
Dynamic Characteristics ²⁾							
Input capacitance	Ciss		-	4760	6200	pF	
Output capacitance	C oss	$V_{GS} = 0 \text{ V}, V_{DS} = 75 \text{ V}, f = 1 \text{ MHz}$	_	1370	1780		
Reverse transfer capacitance	C _{rss}		-	27	40		
Turn-on delay time	t _{d(on)}		-	18	-	ns	
Rise time	t _r	$V_{DD} = 75 \text{ V}, V_{GS} = 10 \text{ V},$ $I_{D} = 85 \text{ A}, R_{G} = 3.5 \Omega$	_	43	-		
Turn-off delay time	t _{d(off)}		_	27	_		
Fall time	t _f		_	39	_		

Gate Charge Characteristics2)

Gate to source charge	Q _{gs}		-	26	33	nC
Gate to drain charge	Q _{gd}	$V_{DD} = 75 \text{ V}, I_{D} = 85 \text{ A},$	_	17	25	
Gate charge total	Qg	$V_{DD} = 75 \text{ V}, I_{D} = 85 \text{ A},$ $V_{GS} = 0 \text{ to } 10 \text{ V}$	-	67	88	
Gate plateau voltage	V _{plateau}		-	5.4	-	V

Reverse Diode

Diode continuous forward current ²⁾	Is	T _C = 25°C	ı	ı	170	А
Diode pulse current ²⁾	I _{S,pulse}	$T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm p} = 100 \mu{\rm s}$	ı	ı	602	
Diode forward voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_F = 85 \text{ A}, T_j = 25^{\circ}\text{C}$	ı	0.9	1.0	V
Reverse recovery time ²⁾	t _{rr}	V _R = 75 V, I _F = 50 A	-	33	50	ns
Reverse recovery charge ²⁾	Q _{rr}	$di_F/dt = 100 A/\mu s$	-	16	32	nC

 $^{^{1)}}$ Practically the current is limited by the overall system design including the customer-specific PCB.

 $^{^{\}rm 2)}$ The parameter is not subject to production testing – specified by design.

³⁾ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7) without thermal vias. PCB is vertical in still air.

⁴⁾ Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7) without thermal vias, heatsink of 71x110x2 mm is attached through TIM with 3.3 W/(m*K) and 400µm thickness to top side pad. Heatsink fixed to 85°C ambient temperature.

⁵⁾ Thermal characterization parameter, calculated as $\psi_{source} = (T_{source} - T_{ambient})/P_{dis}$ in condition of 4). Used to determine PCB temperature at source pins for given power.

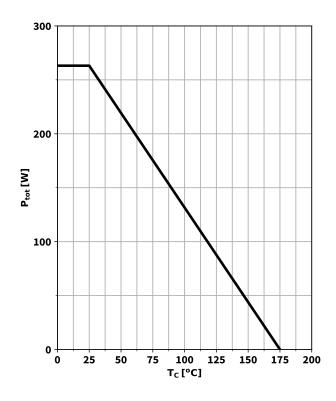
⁶⁾ Thermal characterization parameter, calculated as $\psi_{drain} = (T_{drain} - T_{ambient})/P_{dis}$ in condition of 4). Used to determine PCB temperature at drain pins for given power.



Electrical characteristics diagrams

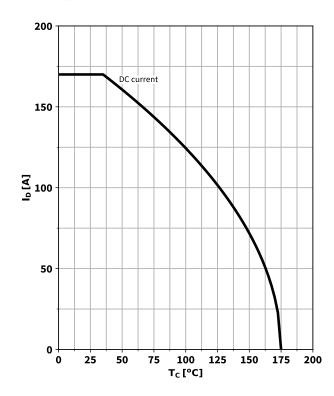
1 Power dissipation

 $P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$



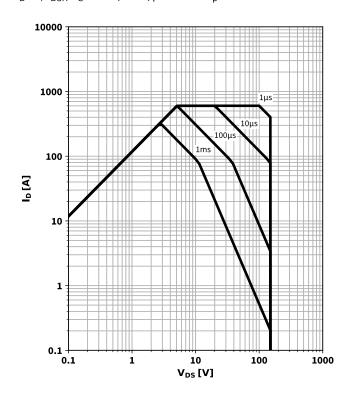
2 Drain current

 $I_{\text{D}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$



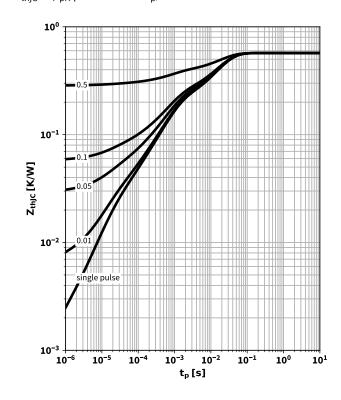
3 Safe operating area

 $I_{\rm D}$ = f($V_{\rm DS}$); $T_{\rm C}$ = 25 °C; D = 0; parameter: $t_{\rm p}$



4 Max. transient thermal impedance

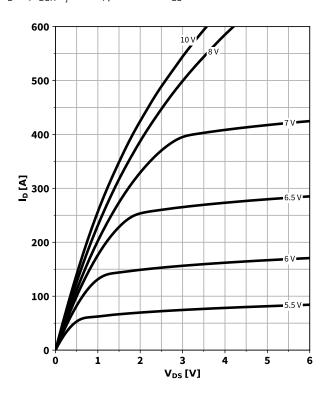
 $Z_{\text{thJC}} = f(t_p)$; parameter: D = t_p/T





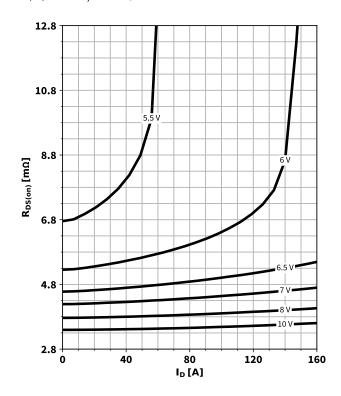
5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \,^{\circ}\text{C}; \text{ parameter: } V_{GS}$



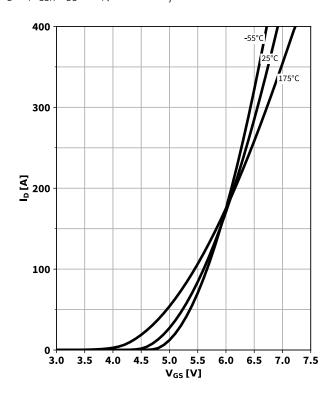
6 Typ. drain-source on-state resistance

 $R_{\mathrm{DS(on)}} = \mathrm{f}(I_{\mathrm{D}}); T_{\mathrm{j}} = 25 \, ^{\circ}\mathrm{C}; \mathrm{parameter}: V_{\mathrm{GS}}$



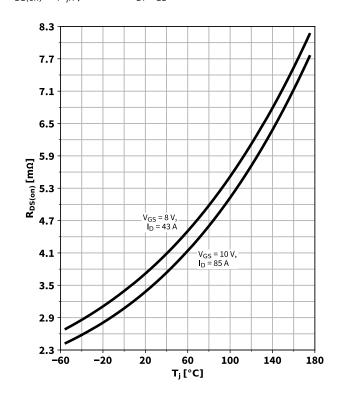
7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6 \text{ V}; \text{ parameter: } T_j$



8 Typ. drain-source on-state resistance

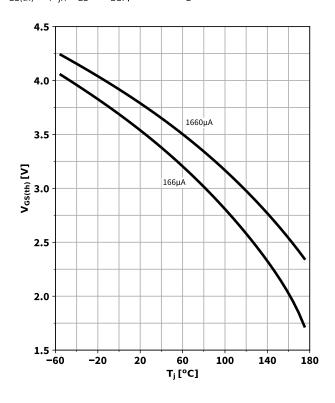
 $R_{DS(on)} = f(T_j)$; parameter: I_D , V_{GS}





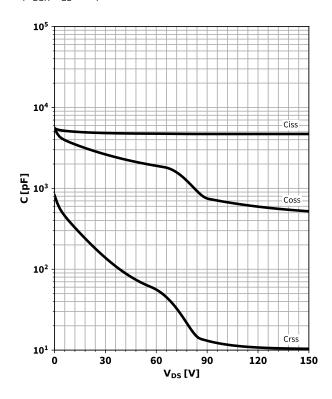
9 Typ. gate threshold voltage

 $V_{\text{GS(th)}} = f(T_{\text{j}}); V_{\text{GS}} = V_{\text{DS}}; \text{ parameter: } I_{\text{D}}$



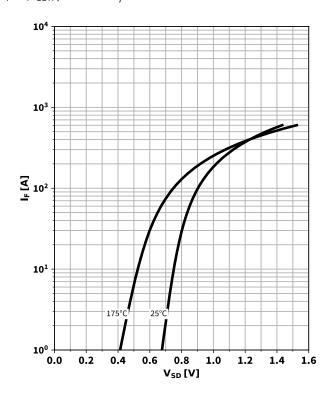
10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$



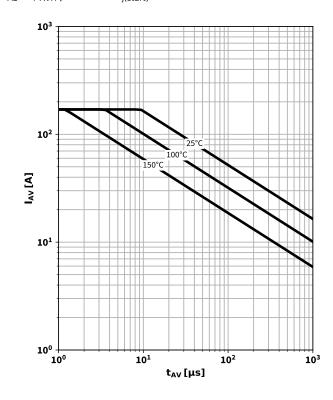
11 Typ. forward diode characteristics

 $I_F = f(V_{SD})$; parameter: T_j



12 Typ. avalanche characteristics

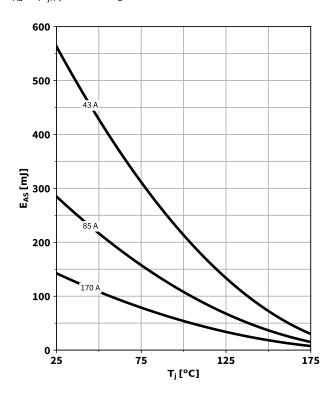
 $I_{AS} = f(t_{AV})$; parameter: $T_{j(start)}$





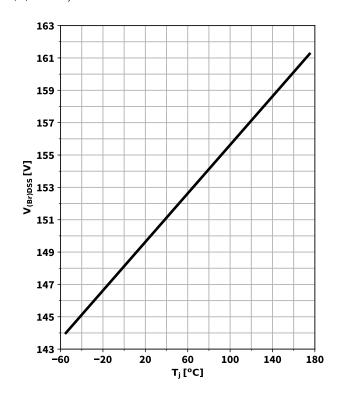
13 Typical avalanche energy

 $E_{AS} = f(T_j)$; parameter: I_D



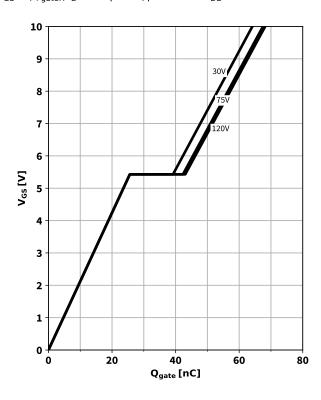
14 Drain-source breakdown voltage

 $V_{(Br)DSS} = f(T_j); I_D = 10 \text{ mA}$

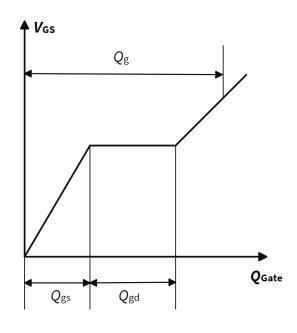


15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 85 \text{ A pulsed}; parameter: } V_{DD}$



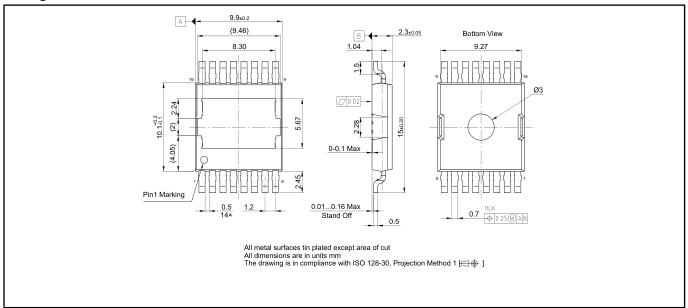
16 Gate charge waveforms



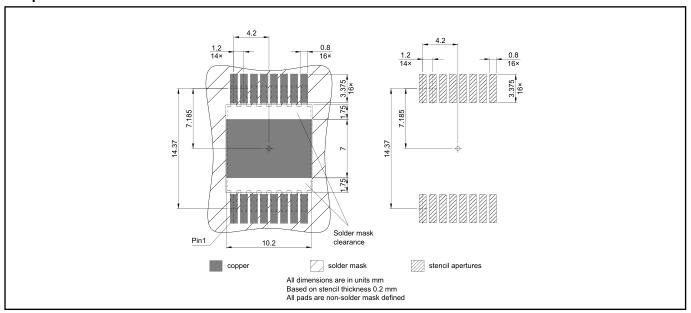
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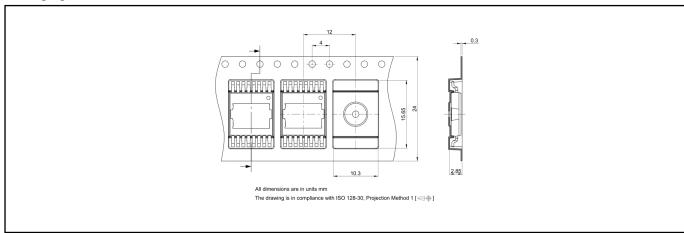
Package Outline



Footprint



Packaging



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Revision History

Revision	Date	Changes
Revision 1.0	14.05.2025	Final data sheet

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